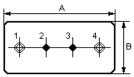
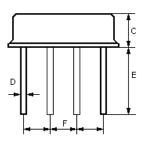


The **ACTQ315/315.0/F11** is a two-port, 180° surface-acoustic-wave (**SAW**) resonator in a low-profile metal **F-11** case. It provides reliable, fundamental-mode, quartz frequency stabilization i.e. in transmitters or local oscillators operating at **315.000** MHz.

2.

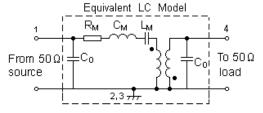
1.Package Dimension (F-11)





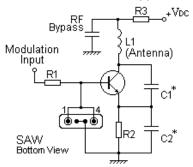
Pin	Configuration				
1,4	Input / Output				
2/3	Case Ground				
Dimension	Data (unit: mm)				
А	11.0±0.3				
В	4.5±0.3				
С	3.2±0.3				
D	0.45±0.1				
E	5.0±0.5				
F	2.54±0.2				

3.Equivalent LC Model and Test Circuit

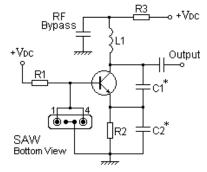


4.Typical Application Circuits

1) Low-Power Transmitter Application



2) Local Oscillator Application



In keeping with our ongoing policy of product evolvement and improvement, the above specification is subject to change without notice.

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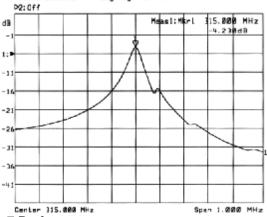
For quotations or further information please contact us at: 3 The Business Centre, Molly Millars Lane, Wokingham, Berks, RG41 2EY, UK <u>http://www.actcrystals.com</u> Issue : 1 C1 Date : SEPT 04



Tel : +44 118 979 1238 Fax : +44 118 979 1283 Email: <u>info@actcrystals.com</u>

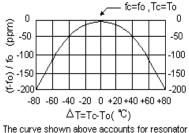
5.Typical Frequency Response

▶1: Transmission /M Log Mag 5.0 dB/ Ref -6.20 dB



7.Performance

6.Temperature Characteristics



The curve shown above accounts for resonator contribution only and does not include LC component temperature characteristics.

7-1.Maximum Ratings						
Rating	Value	Units				
CW RF Power Dissipation	10	dBm				
DC Voltage Between Any Two Pins	±30V	VDC				
Case Temperature	-40 to +85	°C				

	Characteristic	Sym	Minimum	Typical	Maximum	Units
Centre Frequency (+25 °C)	Absolute Frequency	fc	314.925		315.075	MHz
	Tolerance from 315.000MHz	Δf_{C}		±75		kHz
Insertion Loss		IL		5.0	7.0	dB
Quality Factor	Unloaded Q	QU		15,060		
	50 Ω Loaded Q	QL		6,600		
Temperature Stability	Turnover Temperature	T ₀	25		55	°C
	Turnover Frequency	f ₀		fc		kHz
	Frequency Temperature Coefficient	FTC		0.032		ppm/°C ²
Frequency Aging	Absolute Value during the First Year	f _A		≤10		ppm/yr
DC Insulation Resistance Between Any Two Pins			1.0			MΩ
RF Equivalent RLC Model	Motional Resistance	R _M		78	124	Ω
	Motional Inductance	L _M		593.8732		μH
	Motional Capacitance	См		0.4303		fF
	Shunt Static Capacitance	C 0	2.15	2.45	2.75	pF

7-2.Electronic Characteristics

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i CAUTION: Electrostatic Sensitive Device. Observe precautions for handling!

- 1. The frequency f_C is the frequency of minimum IL with the resonator in the specified test fixture in a 50 Ω test system with VSWR \leq 1.2:1. Typically, f_{OSCILLATOR} or f_{TRANSMITTER} is less than the resonator f_C.
- 2. Unless noted otherwise, case temperature $T_c = +25^{\circ}C \pm 2^{\circ}C$. 3. Frequency aging is the change in f_c with time and is specified at +65°C or less. Aging may exceed the specification for prolonged temperatures above +65°C. Typically, aging is greatest the first year after manufacture, decreasing in subsequent years.
- 4. Turnover temperature, \overline{T}_0 , is the temperature of maximum (or turnover) frequency, f_0 . The nominal frequency at any case temperature, T_c, may be calculated from: $f = f_0 [1 - FTC (T_0 - T_c)^2]$. Typically, oscillator T₀ is 20° less than the specified resonator T_0 .
- This equivalent RLC model approximates resonator performance near the resonant frequency and is provided 5. for reference only. The capacitance C_0 is the measured static (non-motional) capacitance between either Pin 1 and ground or Pin 4 and ground. The measurement includes case parasitic capacitance.
- 6. Derived mathematically from one or more of the following directly measured parameters: f _C, IL, 3 dB bandwidth, $f_{\rm C}$ versus $T_{\rm C}$, and C_0 .
- 7. The specifications of this device are based on the test circuit shown above and subject to change or obsolescence without notice.
- 8. Typically, equipment utilizing this device requires emissions testing and government approval, which is the responsibility of the equipment manufacturer.
- 9. Our liability is only assumed for the Surface Acoustic Wave (SAW) component(s) per se, not for applications, processes and circuits implemented within components or assemblies.

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